# 74AHC1G4212

# 12-stage divider and oscillator Rev. 1 — 15 April 2016

**Product data sheet** 

#### 1. **General description**

74AHC1G4212 is a 12-stage divider and oscillator. It consists of a chain of 12 flip-flops. Each flip-flop divides the frequency of the previous flip-flop by two, consequently the 74AHC1G4212 counts up to  $2^{12}$  = 4096. The single inverting stage (X1 to X2) functions as a crystal oscillator or an input buffer for an external oscillator. When used as a buffer the output X2 should be left floating. The frequency of the output (Q) is the frequency applied to X1 divided by 4096. The divider advances on the negative-going transition of X1.

The X1 input is overvoltage tolerant. This feature allows the use of this device as a voltage level translator in mixed voltage environments.

#### **Features and benefits** 2.

- Wide supply voltage range from 2.0 V to 5.5 V
- Overvoltage tolerant inputs to 5.5 V
- High noise immunity
- CMOS low power dissipation
- ESD protection:
  - HBM JESD22-A114F: exceeds 2000 V
  - CDM JESD22-C101E: exceeds 1000 V
- Latch-up performance exceeds 100 mA per JESD 78 Class II
- Specified from -40 °C to +85 °C and -40 °C to +125 °C

#### Ordering information 3.

Table 1. **Ordering information** 

Type number	Package										
	Temperature range	Name	Description	Version							
74AHC1G4212GW	–40 °C to +125 °C	TSSOP5	plastic thin shrink small outline package; 5 leads; body width 1.25 mm	SOT353-1							
74AHC1G4212GM	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 × 1.45 × 0.5 mm	SOT886							



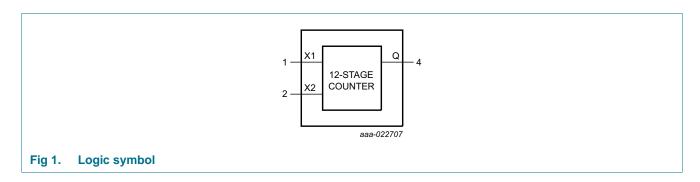
# 4. Marking

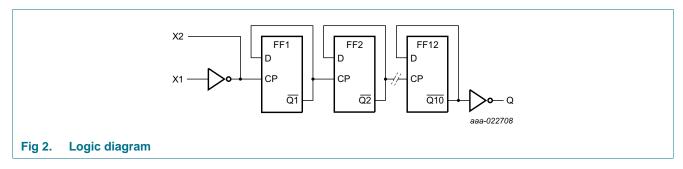
Table 2. Marking codes

Type number	Marking <sup>[1]</sup>
74AHC1G4212GW	C2
74AHC1G4212GM	C2

<sup>[1]</sup> The pin 1 indicator is located on the lower left corner of the device, below the marking code.

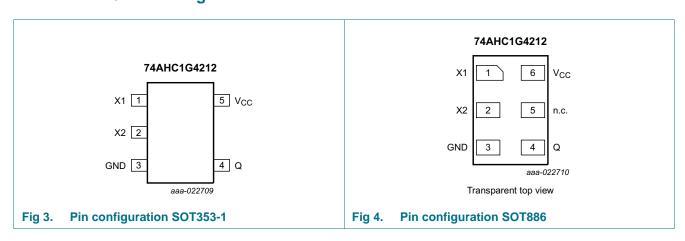
# 5. Functional diagram





# 6. Pinning information

### 6.1 Pinning



74AHC1G4212

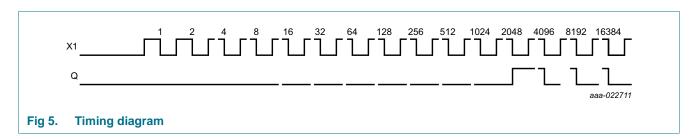
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### 6.2 Pin description

Table 3. Pin description

Symbol	Pin	Pin					
	SOT353-1	SOT886					
X1	1	1	clock input/oscillator pin				
X2	2	2	oscillator pin				
GND	3	3	ground (0 V)				
Q	4	4	divider output				
n.c.	-	5	not connected				
V <sub>CC</sub>	5	6	supply voltage				

# 7. Functional description



# 8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage			-0.5	+7.0	V
VI	input voltage			-0.5	+7.0	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < -0.5 V		-20	-	mA
I <sub>OK</sub>	output clamping current	$V_{O} < -0.5 \text{ V or } V_{O} > V_{CC} + 0.5 \text{ V}$	[1]	-	±20	mA
Io	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$		-	±25	mA
I <sub>CC</sub>	supply current			-	75	mA
I <sub>GND</sub>	ground current			<b>-75</b>	-	mA
T <sub>stg</sub>	storage temperature			-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +125  ^{\circ}\text{C}$	[2]	-	250	mW

<sup>[1]</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>[2]</sup> For TSSOP5 package: above 87.5 °C the value of  $P_{tot}$  derates linearly with 4.0 mW/K. For XSON6 package: above 118 °C the value of  $P_{tot}$  derates linearly with 7.8 mW/K.

# 9. Recommended operating conditions

Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		2.0	5.0	5.5	V
VI	input voltage		0	-	5.5	V
Vo	output voltage		0	-	V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature		-40	+25	+125	°C
Δt/ΔV	input transition rise and fall	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$	-	-	100	ns/V
	rate	$V_{CC} = 5.0 \text{ V} \pm 0.5 \text{ V}$	-	-	20	ns/V

# 10. Static characteristics

### Table 6. Static characteristics

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		-40 °C 1	to +85 °C	-40 °C t	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
$V_{IH}$	HIGH-level	X1								
	input voltage	V <sub>CC</sub> = 2.0 V	1.7	-	-	1.7	-	1.7	-	V
		V <sub>CC</sub> = 3.0 V	2.4	-	-	2.4	-	2.4	-	V
		V <sub>CC</sub> = 5.5 V	4.4	-	-	4.4	-	4.4	-	V
$V_{IL}$	LOW-level	X1								
	input voltage	V <sub>CC</sub> = 2.0 V	-	-	0.3	-	0.3	-	0.3	V
		V <sub>CC</sub> = 3.0 V	-	-	0.6	-	0.6	-	0.6	V
		V <sub>CC</sub> = 5.5 V	-	-	1.1	-	1.1	-	1.1	V
$V_{OH}$	HIGH-level output voltage	Q; $V_I = V_{IH}$ or $V_{IL}$								
		$I_O = -50 \mu A; V_{CC} = 2.0 V$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -50 \mu A; V_{CC} = 3.0 \text{ V}$	2.9	3.0	-	2.9	-	2.9	-	V
		$I_O = -50 \mu A; V_{CC} = 4.5 V$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.58	-	-	2.48	-	2.40	-	V
		$I_{O} = -8.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.94	-	-	3.8	-	3.70	-	V
		$X2; V_I = V_{IH} \text{ or } V_{IL}$								
		$I_O = -50 \mu A; V_{CC} = 2.0 \text{ V}$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -50 \mu A; V_{CC} = 3.0 \text{ V}$	2.9	3.0	-	2.9	-	2.9	-	V
		$I_O = -50 \mu A; V_{CC} = 4.5 V$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -2.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.58	-	-	2.48	-	2.40	-	V
		$I_{O} = -3.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.94	-	-	3.8	-	3.70	-	V

**Table 6. Static characteristics** ...continued Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		-40 °C	to +85 °C	-40 °C t	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
V <sub>OL</sub>	LOW-level	$Q; V_I = V_{IH} \text{ or } V_{IL}$								
	output voltage	$I_O = 50 \mu A; V_{CC} = 2.0 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 50 \mu A; V_{CC} = 3.0 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 50 \mu A; V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 4.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.36	-	0.44	-	0.55	V
		$I_O = 8.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.36	-	0.44	-	0.55	V
		$X2; V_I = V_{IH} \text{ or } V_{IL}$								
		$I_O = 50 \mu A; V_{CC} = 2.0 \text{ V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 50 \mu A; V_{CC} = 3.0 \text{ V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 50 \mu A; V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 2.0 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.36	-	0.44	-	0.55	V
		$I_O = 3.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.36	-	0.44	-	0.55	V
I <sub>I</sub>	input leakage current	X1; $V_I = 5.5 \text{ V or GND}$ ; $V_{CC} = 0 \text{ V to } 5.5 \text{ V}$	-	-	0.1	-	1.0	-	2.0	μΑ
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	1.0	-	10	-	40	μΑ
Cı	input capacitance	X1	-	3	8	-	8	-	8	pF

# 11. Dynamic characteristics

Table 7. Dynamic characteristics

GND = 0 V;  $t_r = t_f = \le 3.0$  ns. For test circuit see <u>Figure 8</u>. For waveforms see <u>Figure 6</u> and <u>Figure 7</u>.

Symbol	Parameter	Conditions			25 °C		-40 °C	to +85 °C	-40 °C 1	to +125 °C	Unit
				Min	Тур	Max	Min	Max	Min	Max	
t <sub>pd</sub>	propagation	X1 to X2	[1]								
	delay	V <sub>CC</sub> = 3.0 V to 3.6 V	[2]								
		C <sub>L</sub> = 15 pF		-	3	7	1	11	1	13	ns
		C <sub>L</sub> = 50 pF		-	7	13	1	16	1	18	ns
		V <sub>CC</sub> = 4.5 V to 5.5 V	[3]								
		C <sub>L</sub> = 15 pF		-	2	5	1	7	1	9	ns
		C <sub>L</sub> = 50 pF		-	6	10	1	11	1	12	ns
		X1 to Q	[1]								
		V <sub>CC</sub> = 3.0 V to 3.6 V	[2]								
		C <sub>L</sub> = 15 pF		-	28	48	1	59	1	68	ns
		C <sub>L</sub> = 50 pF		-	31	52	1	62	1	73	ns
		V <sub>CC</sub> = 4.5 V to 5.5 V	[3]								
		C <sub>L</sub> = 15 pF		-	20	31	1	39	1	45	ns
		C <sub>L</sub> = 50 pF		-	22	35	1	45	1	51	ns

 Table 7.
 Dynamic characteristics ...continued

GND = 0 V;  $t_r = t_f = \le 3.0$  ns. For test circuit see <u>Figure 8</u>. For waveforms see <u>Figure 6</u> and <u>Figure 7</u>.

		·								
Symbol	Parameter	Conditions		25 °C			to +85 °C	–40 °C t	o +125 °C	Unit
				Тур	Max	Min	Max	Min	Max	
t <sub>W</sub>	pulse width	X1 HIGH or LOW								
		V <sub>CC</sub> = 3.0 V to 3.6 V	4	-	-	5	-	7	-	ns
		V <sub>CC</sub> = 4.5 V to 5.5 V	3	-	-	4	-	5	-	ns
f <sub>max</sub>	maximum	X1								
	frequency	V <sub>CC</sub> = 3.3 V	125	-	-	100	-	70	-	MHz
		V <sub>CC</sub> = 5 V	165	-	-	125	-	100	-	MHz
C <sub>PD</sub>	power dissipation	$C_L$ = 50 pF; $f_i$ = 1 MHz; $V_I$ = GND to $V_{CC}$								
	capacitance	V <sub>CC</sub> = 3.3 V	1 -	4	-	-	-	-	-	pF
		V <sub>CC</sub> = 5 V	1 -	5	-	-	-	-	-	pF

- [1]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .
- [2] Typical values are measured at  $V_{CC} = 3.3 \text{ V}$ .
- [3] Typical values are measured at  $V_{CC}$  = 5.0 V.
- [4]  $C_{PD}$  is used to determine the dynamic power dissipation  $P_D$  ( $\mu W$ ).

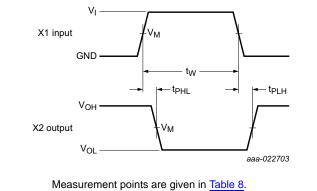
$$P_D = C_{PD} \times V_{CC}{}^2 \times f_i + C_L \times V_{CC}{}^2 \times f_i / 4096$$
 where:

 $f_i$  = input frequency in MHz;

C<sub>L</sub> = output load capacitance in pF;

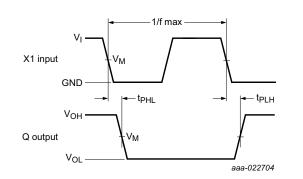
V<sub>CC</sub> = supply voltage in Volts.

## 12. Waveforms



 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical output voltage levels that occur with the output load.

Fig 6. Input X1 to output X2 propagation delay times



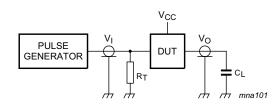
Measurement points are given in Table 8.

V<sub>OL</sub> and V<sub>OH</sub> are typical output voltage levels that occur with the output load.

Input X1 to output Q propagation delay times Fig 7.

Table 8. **Measurement points** 

Inputs	Output	
VI	V <sub>M</sub>	V <sub>M</sub>
GND to V <sub>CC</sub>	0.5 × V <sub>CC</sub>	$0.5 \times V_{CC}$



Test data is given in Table 7. Definitions for test circuit:

C<sub>L</sub> = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

Test circuit for measuring switching times Fig 8.

# 13. Crystal oscillator

### 13.1 Typical crystal oscillator circuit

A typical crystal oscillator schematic is shown in <u>Figure 9</u>. R1 is the power limiting resistor, its value depends on the frequency and required stability against changes in  $V_{CC}$  or average  $I_{CC}$ . For starting and maintaining oscillation a minimum transconductance is necessary, so R1 should not be too large. A practical value for R1 is 2.2 k $\Omega$ .

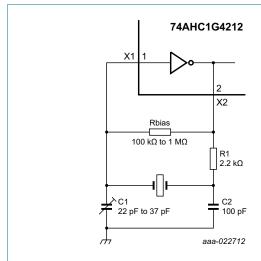
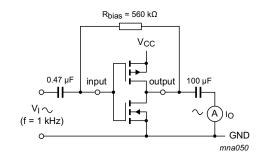


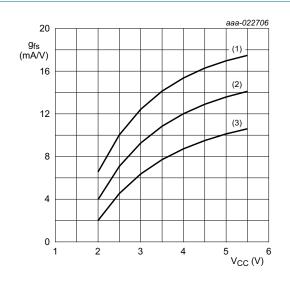
Fig 9. External component connection for a crystal oscillator



 $g_{fs} = \Delta I_O \: / \: \Delta V_I$  at  $V_O$  is constant.

See also Figure 11.

Fig 10. Test set-up for measuring forward transconductance



 $T_{amb}$  = 25 °C.

- (1) Maximum.
- (2) Typical.
- (3) Minimum.

Fig 11. Typical forward transconductance as function of the supply voltage

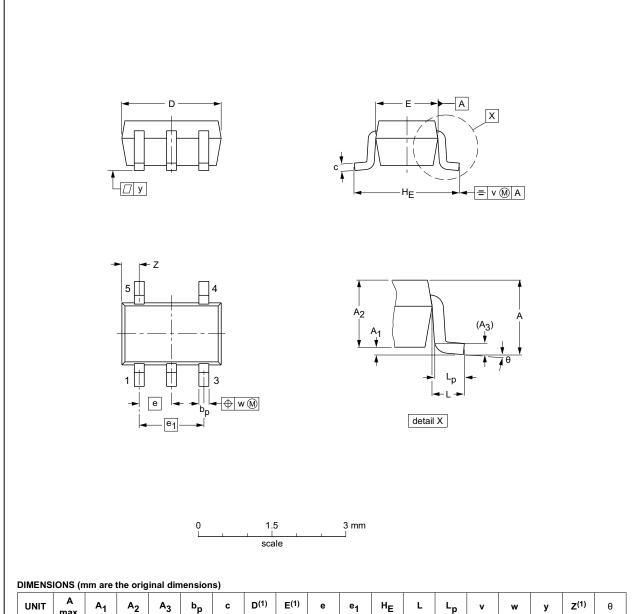
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# 14. Package outline

TSSOP5: plastic thin shrink small outline package; 5 leads; body width 1.25 mm

SOT353-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	С	D <sup>(1)</sup>	E(1)	е	e <sub>1</sub>	HE	L	Lp	v	w	у	Z <sup>(1)</sup>	θ
mm	1.1	0.1 0	1.0 0.8	0.15	0.30 0.15	0.25 0.08	2.25 1.85	1.35 1.15	0.65	1.3	2.25 2.0	0.425	0.46 0.21	0.3	0.1	0.1	0.60 0.15	7° 0°

#### Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT353-1		MO-203	SC-88A			<del>00-09-01</del> 03-02-19	

Fig 12. Package outline SOT353-1 (TSSOP5)

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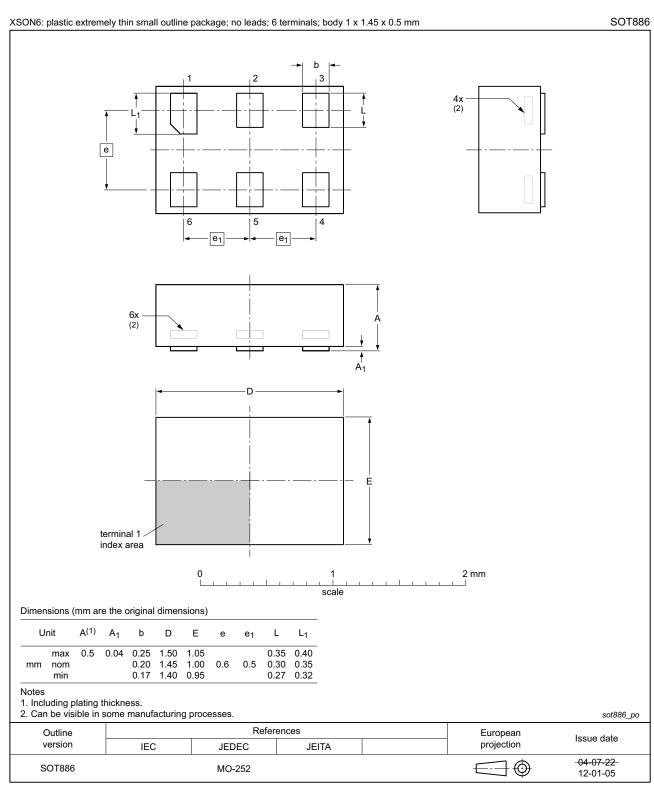


Fig 13. Package outline SOT886 (XSON6)

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# 15. Abbreviations

### Table 9. Abbreviations

Acronym	Description
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model

# 16. Revision history

### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74AHC1G4212 v.1	20160415	Product data sheet	-	-

# 17. Legal information

### 17.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
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### 12-stage divider and oscillator

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### 17.4 Trademarks

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### 18. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

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Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

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- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов:
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- Поставка сложных, дефицитных, либо снятых с производства позиций;
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- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001:
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- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



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